


<b>Search Notes</b>  	<b>Application/Control No.</b>  10582090	<b>Applicant(s)/Patent Under Reexamination</b>  IMAI, KAZUHIRO
	<b>Examiner</b>  Leon Y Lum	<b>Art Unit</b>  1641

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search in eDAN, PALM and STN (search history attached). Search included copending and patented claims for double patenting analysis.	1/14/09	LYL
EAST search using keywords (search history attached).	1/14/09	LYL
STIC search on structures of claims 13 and 14	3/12/09	LYL
STIC search on structures of claims 21 and 22	3/18/09	LL
Discussed the prior art, including STIC search, and claims 21 and 22 with Mark Shibuya and Nelson Yang, who suggested broadening the search.	3/20/09	LYL
STN search using keywords (search history attached).	3/24/09	LYL
Discuss STIC search on 3/18/09 and claims 21 and 22 with Shafiqul Haq, who suggested broadening the search.	3/25/09	LYL
Refined STIC search.	3/25/09	LYL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/Leon Y Lum/ Examiner.Art Unit 1641	
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